



STK850

N-channel 30V - 0.0024Ω - 30A - PolarPAK®
STripFET™ Power MOSFET

Features

| Type | V _{DSS} | R _{DS(on)} | R _{DS(on)} *Q _g | P _{TOT} |
|--------|------------------|---------------------|-------------------------------------|------------------|
| STK850 | 30V | <0.0029Ω | 71nC*mΩ | 5.2W |

- Ultra low top and bottom junction to case thermal resistance
- Very low capacitances
- 100% R_g tested
- Fully encapsulated die
- 100% Matte tin finish (in compliance with the 2002/95/EC european directive)
- PolarPAK® is a trademark of VISHAY

Application

- Switching applications

Description

This Power MOSFET is the latest development of STMicroelectronics unique “single feature size” strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, moreover the double sides cooling package with ultra low junction to case thermal resistance allows to handle higher levels of current.

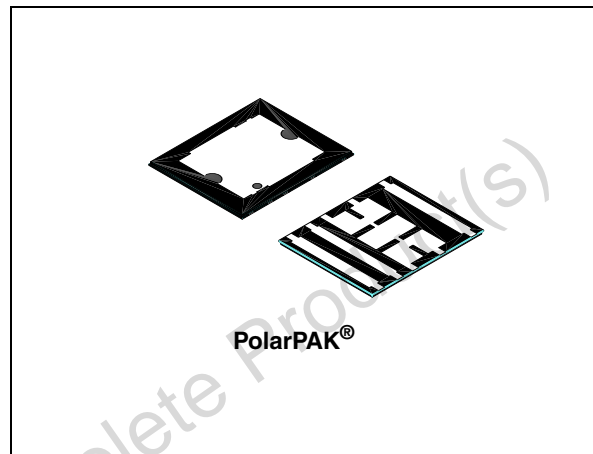


Figure 1. Internal schematic diagram

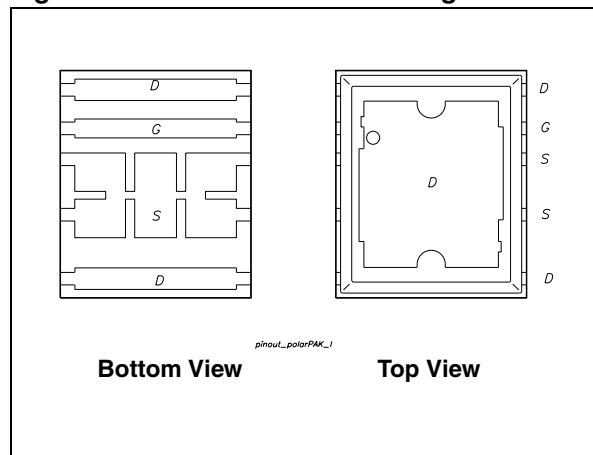


Table 1. Device summary

| Order code | Marking | Package | Packaging |
|------------|---------|-----------|-------------|
| STK850 | K850 | PolarPAK® | Tape & reel |

Contents

| | | |
|----------|---|-----------|
| 1 | Electrical ratings | 3 |
| 2 | Electrical characteristics | 4 |
| 2.1 | Electrical characteristics (curves) | 6 |
| 3 | Test circuits | 9 |
| 4 | Package mechanical data | 11 |
| 5 | Revision history | 15 |

Obsolete Product(s) - Obsolete Product(s)

1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|--------------------|---|------------|---------------------|
| V_{DS} | Drain-source voltage ($V_{GS} = 0$) | 30 | V |
| $V_{GS}^{(1)}$ | Gate-source voltage | ± 16 | V |
| $V_{GS}^{(2)}$ | Gate-source voltage | ± 18 | V |
| $I_D^{(4)}$ | Drain current (continuous) at $T_C = 25^\circ\text{C}$ | 30 | A |
| I_D | Drain current (continuous) at $T_C = 100^\circ\text{C}$ | 18.75 | A |
| $I_{DM}^{(3)}$ | Drain current (pulsed) | 120 | A |
| $P_{TOT}^{(4)}$ | Total dissipation at $T_C = 25^\circ\text{C}$ | 5.2 | W |
| | Derating factor | 0.0416 | W/ $^\circ\text{C}$ |
| $E_{AS}^{(5)}$ | Single pulse avalanche energy | 1.4 | J |
| T_J T_{stg} | Operating junction temperature Storage temperature | -55 to 150 | $^\circ\text{C}$ |

1. Continuous mode
2. Guaranteed for test time $\leq 15\text{ms}$
3. Pulse width limited by package
4. When mounted on FR-4 board of 1inch^2 , 2 oz. Cu. and $\leq 10\text{sec}$
5. Starting $T_J = 25^\circ\text{C}$, $I_D = 15\text{A}$, $V_{DD} = 25\text{V}$

Table 3. Thermal data

| Symbol | Parameter | Typ. | Max. | Unit |
|---------------------|--|------|------|---------------------------|
| $R_{thj-amb}^{(1)}$ | Thermal resistance junction-amb | 20 | 24 | $^\circ\text{C}/\text{W}$ |
| $R_{thj-c}^{(2)}$ | Thermal resistance junction-case (top drain) | 0.8 | 1 | $^\circ\text{C}/\text{W}$ |
| $R_{thj-c}^{(3)}$ | Thermal resistance junction-case (source) | 2.2 | 2.7 | $^\circ\text{C}/\text{W}$ |

1. When mounted on FR-4 board of 1inch^2 , 2 oz. Cu. and $\leq 10\text{sec}$
2. Steady State
3. Measured at Source pin when the device is mounted on FR-4 board in steady state

2 Electrical characteristics

($T_{CASE}=25^{\circ}C$ unless otherwise specified)

Table 4. On/off

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|--|---|------|------------------|------------------|----------------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $I_D = 250\mu A, V_{GS} = 0$ | 30 | | | V |
| I_{DSS} | Zero gate voltage drain current ($V_{GS} = 0$) | $V_{DS} = \text{Max rating},$ $V_{DS} = \text{Max rating}, T_c = 125^{\circ}C$ | | | 1 10 | μA μA |
| I_{GSS} | Gate body leakage current ($V_{DS} = 0$) | $V_{GS} = \pm 16V$ | | | ± 100 | nA |
| $V_{GS(th)}$ | Gate threshold voltage | $V_{DS} = V_{GS}, I_D = 250\mu A$ | 1 | | 2.5 | V |
| $R_{DS(on)}$ | Static drain-source on resistance | $V_{GS} = 10V, I_D = 15A$ $V_{GS} = 4.5V, I_D = 15A$ | | 0.0024 0.0029 | 0.0029 0.0035 | Ω Ω |

Table 5. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|-------------------------------------|---|------|------|------|----------|
| C_{iss} | Input capacitance | | | 3150 | | pF |
| C_{oss} | Output capacitance | $V_{DS} = 25V, f = 1 \text{ MHz}, V_{GS} = 0$ | | 940 | | pF |
| C_{rss} | Reverse transfer capacitance | | | 90 | | pF |
| Q_g | Total gate charge | $V_{DD} = 15V, I_D = 30A$ | | 24.5 | 32.5 | nC |
| Q_{gs} | Gate-source charge | $V_{GS} = 4.5V$ | | 8 | | nC |
| Q_{gd} | Gate-drain charge | (see Figure 16) | | 8.2 | | nC |
| Q_{gs1} | Pre V_{th} gate-to-source charge | $V_{DD} = 15V, I_D = 12A$ $V_{GS} = 4.5V$ | | 0.6 | | nC |
| Q_{gs2} | Post V_{th} gate-to-source charge | (see Figure 21) | | 7.2 | | nC |
| R_G | Gate input resistance | $f = 1 \text{ MHz}$ Gate DC Bias = 0 Test signal level = 20mV open drain | | 1.1 | | Ω |

Table 6. Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------------|----------------------------------|--|------|----------|------|----------|
| $t_{d(on)}$ t_r | Turn-on delay time Rise time | $V_{DD}=15V, I_D=15A,$ $R_G=4.7\Omega, V_{GS}=4.5V$ <i>(see Figure 15)</i> | | 20 57 | | ns ns |
| $t_{d(off)}$ t_f | Turn-off delay time Fall time | $V_{DD}=15V, I_D=15A,$ $R_G=4.7\Omega, V_{GS}=4.5V$ <i>(see Figure 15)</i> | | 31 13 | | ns ns |

Table 7. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------------------------|--|--|------|-----------------|-----------|---------------|
| I_{SD} $I_{SDM}^{(1)}$ | Source-drain current Source-drain current (pulsed) | | | | 30 120 | A A |
| $V_{SD}^{(2)}$ | Forward on voltage | $I_{SD}=15A, V_{GS}=0$ | | | 1.2 | V |
| t_{rr} Q_{rr} I_{RRM} | Reverse recovery time Reverse recovery charge Reverse recovery current | $I_{SD}=30A, di/dt=100A/\mu s,$ $V_{DD}=20V, T_J=150^\circ C$ <i>(see Figure 20)</i> | | 39 39.8 2 | | ns nC A |

1. Pulse width limited by package
2. Pulsed: pulse duration = 300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

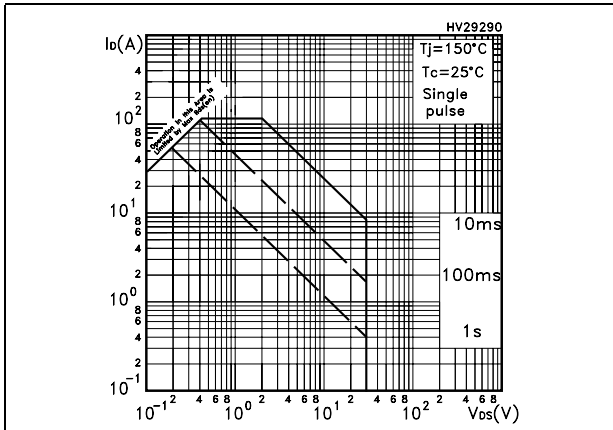


Figure 3. Thermal impedance

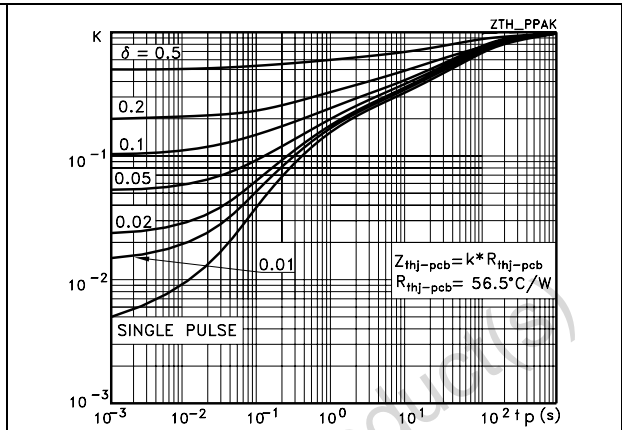


Figure 4. Output characteristics

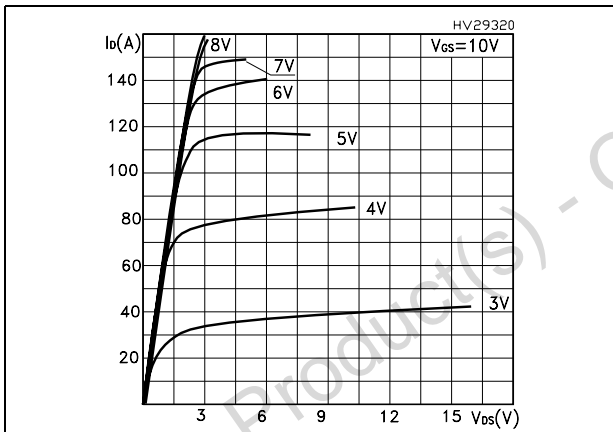


Figure 5. Transfer characteristics

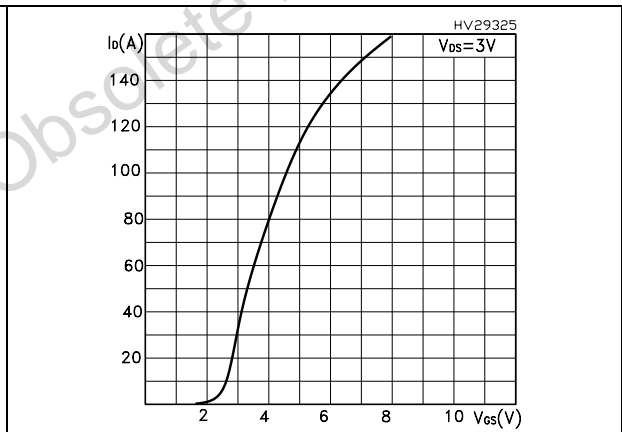


Figure 6. Transconductance

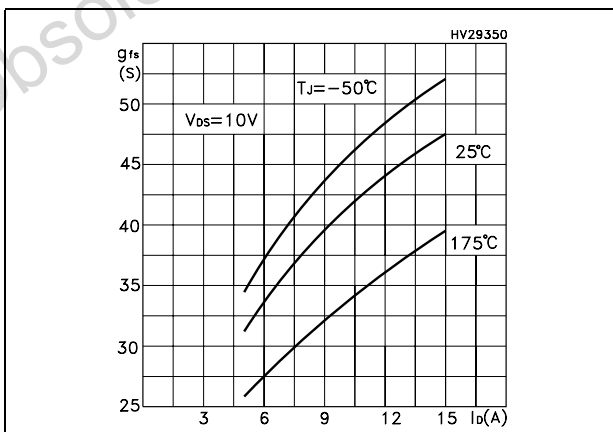


Figure 7. Static drain-source on resistance

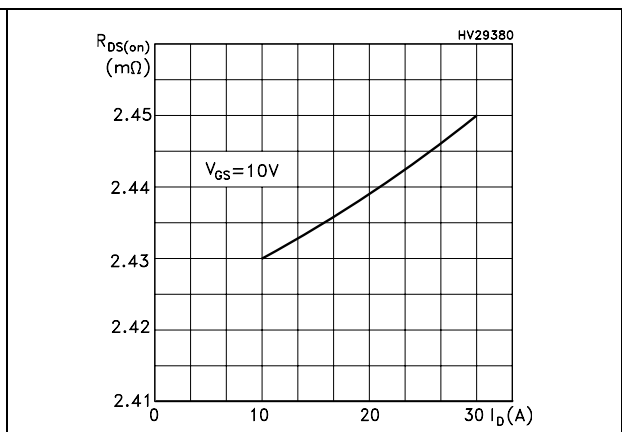


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

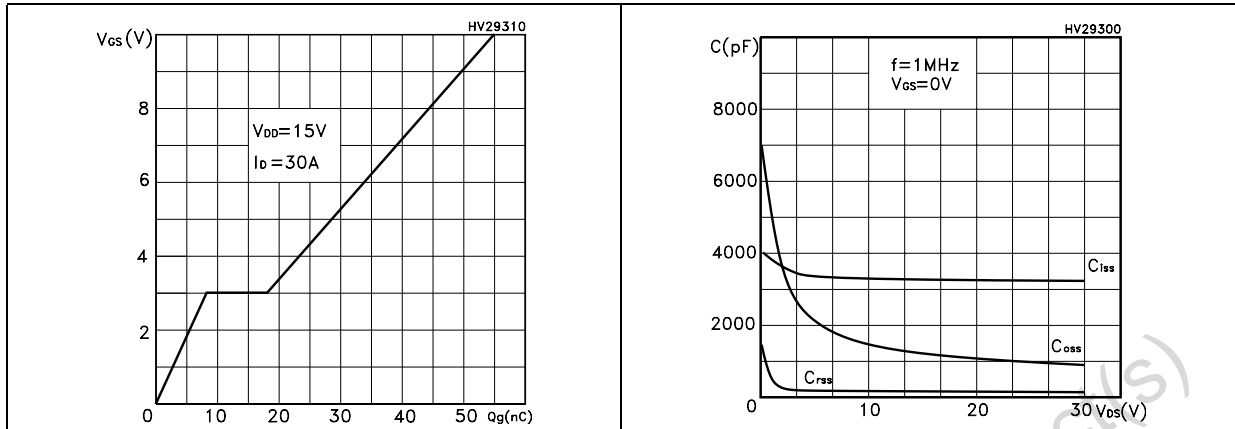


Figure 10. Normalized gate threshold voltage vs temperature Figure 11. Normalized on resistance vs temperature

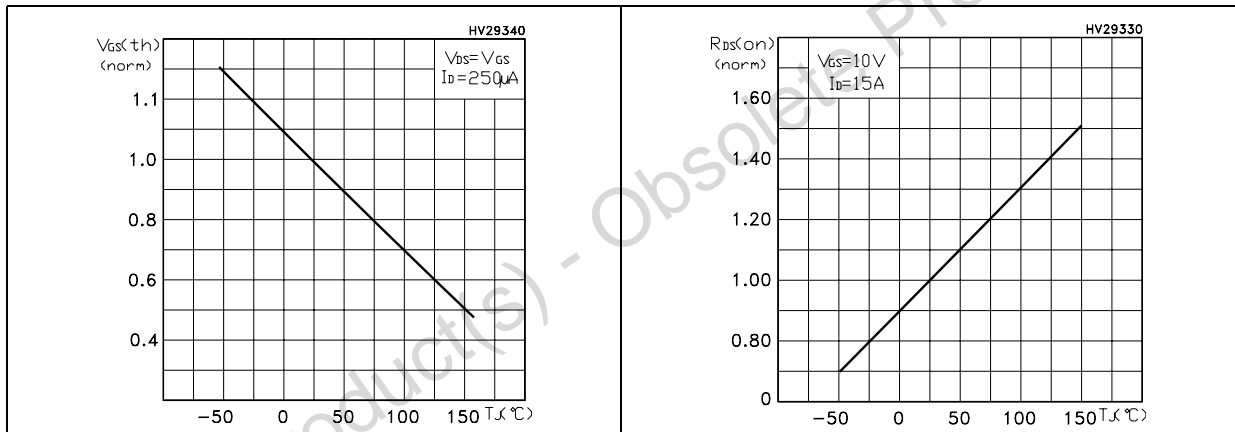


Figure 12. Source-drain diode forward characteristics Figure 13. Normalized B_{VDSS} vs temperature

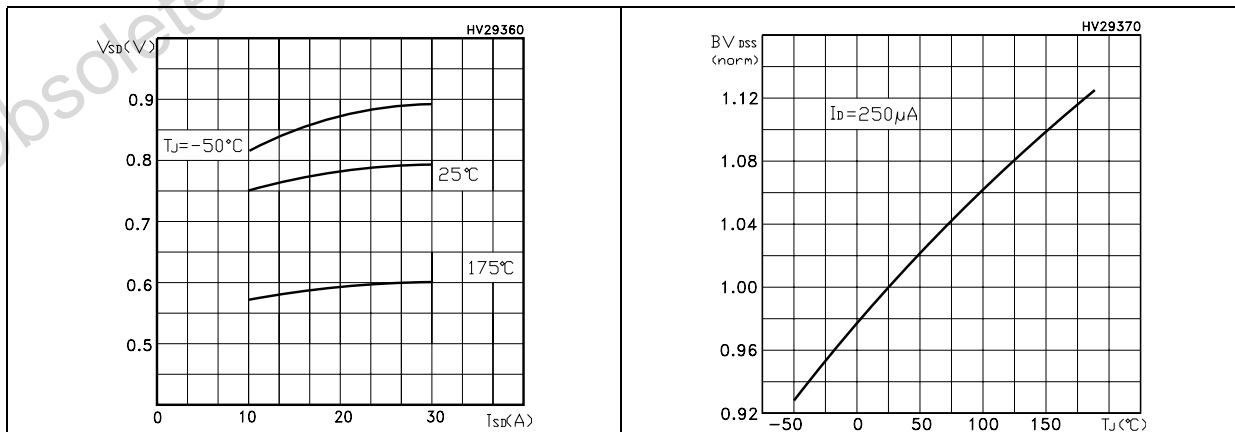
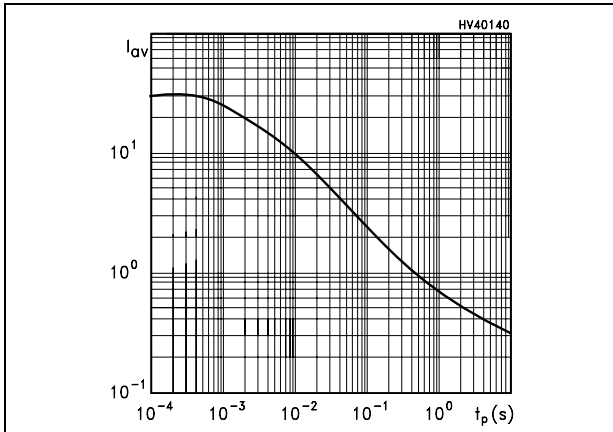


Figure 14. Allowable I_{AV} vs time in avalanche



The previous curve gives the single pulse safe operating area for unclamped inductive loads, under the following conditions:

$$P_{D(AVE)} = 0.5 \cdot (1.3 \cdot B_{VDSS} \cdot I_{AV})$$

$$E_{AS(AR)} = P_{D(AVE)} \cdot t_{AV}$$

Where:

I_{AV} is the allowable current in avalanche

$P_{D(AVE)}$ is the average power dissipation in avalanche (single pulse)

t_{AV} is the time in avalanche

3 Test circuits

Figure 15. Switching times test circuit for resistive load

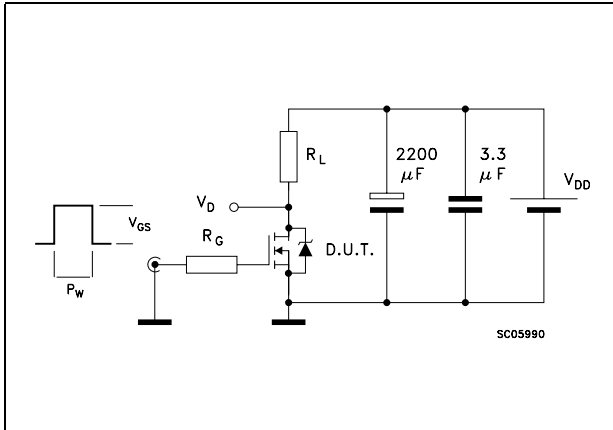


Figure 16. Gate charge test circuit

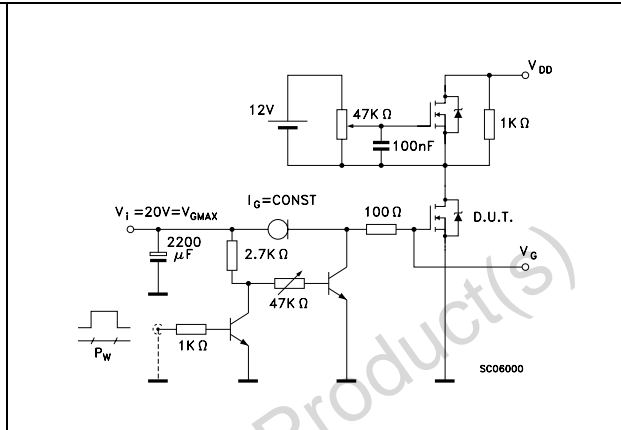


Figure 17. Test circuit for inductive load switching and diode recovery times

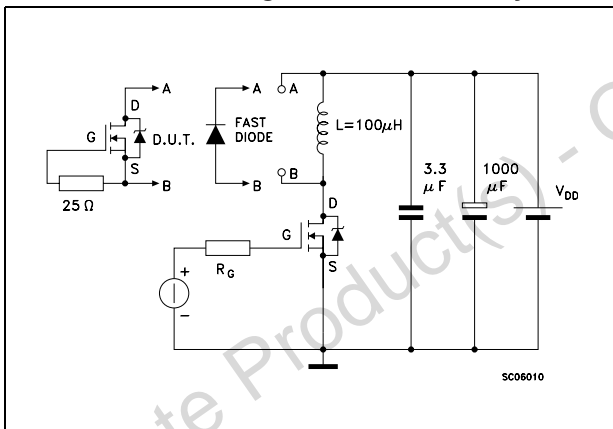


Figure 18. Unclamped inductive load test circuit

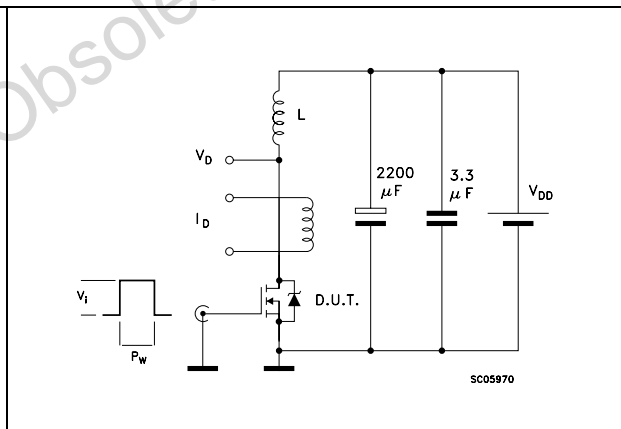


Figure 19. Unclamped inductive waveform

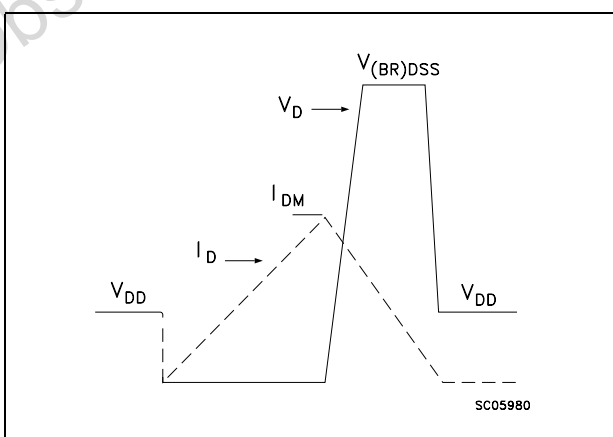


Figure 20. Switching time waveform

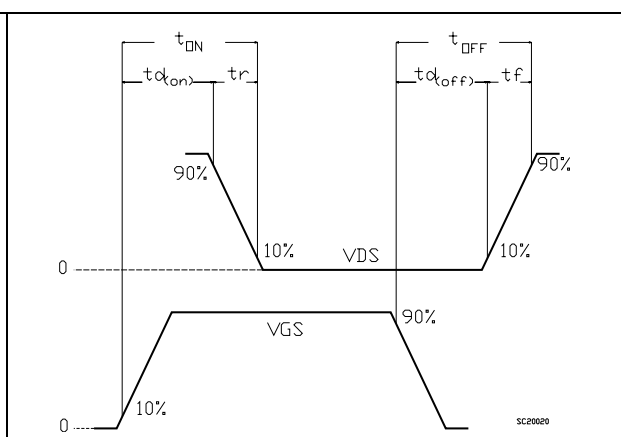
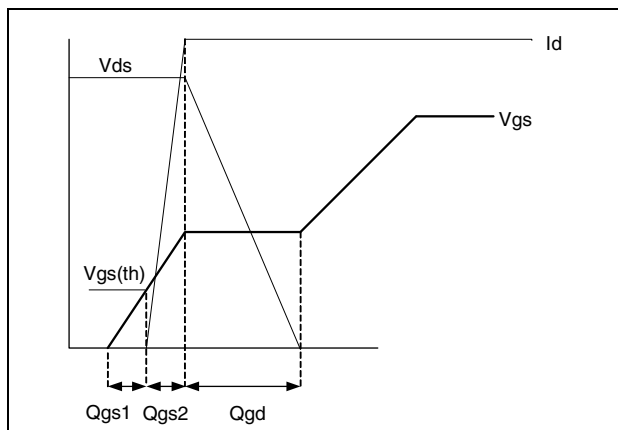


Figure 21. Gate charge waveform



Obsolete Product(s) - Obsolete Product(s)

4 Package mechanical data

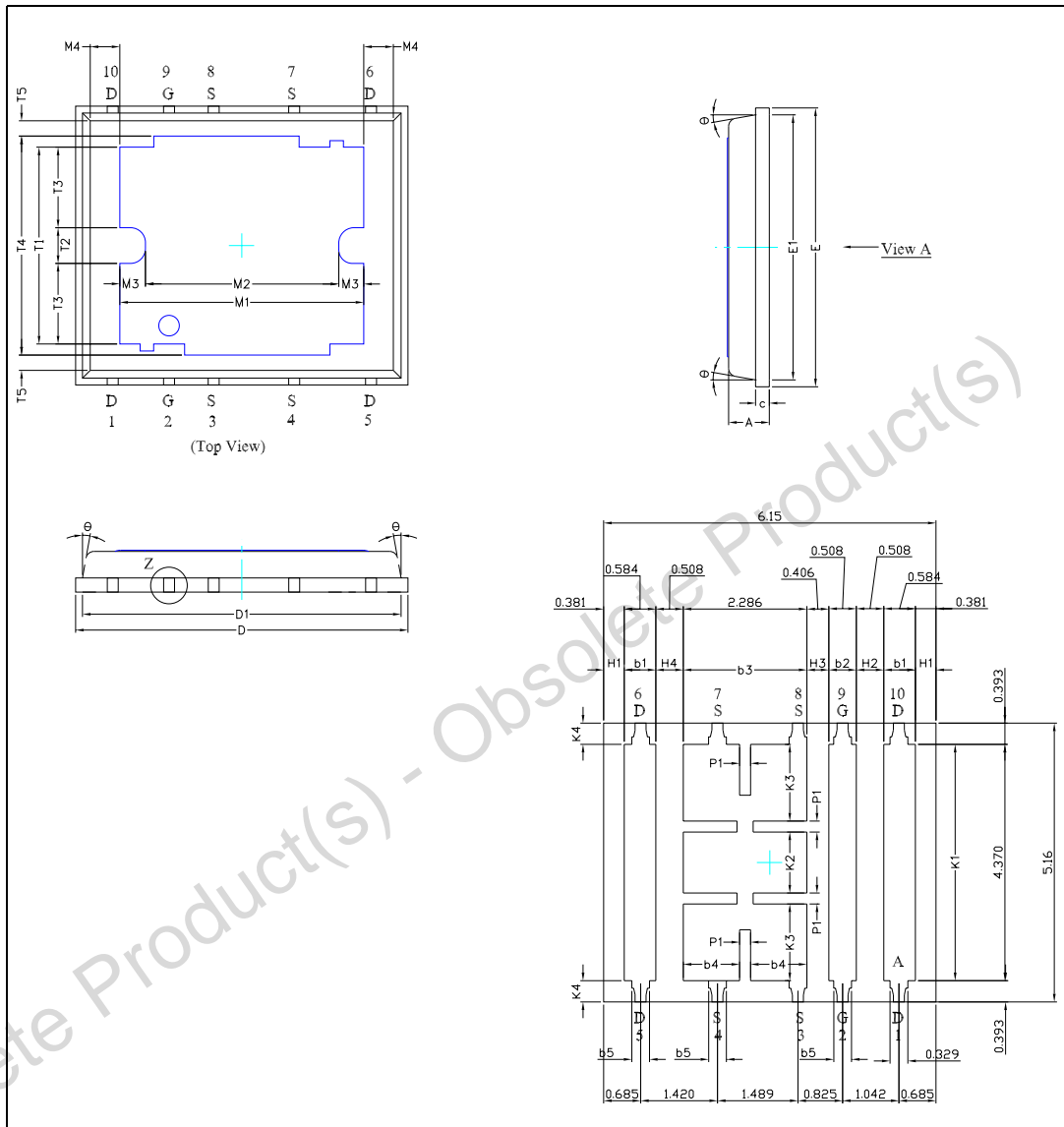
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

Obsolete Product(s) - Obsolete Product(s)

Table 8. PolarPAK® (option "L") mechanical data

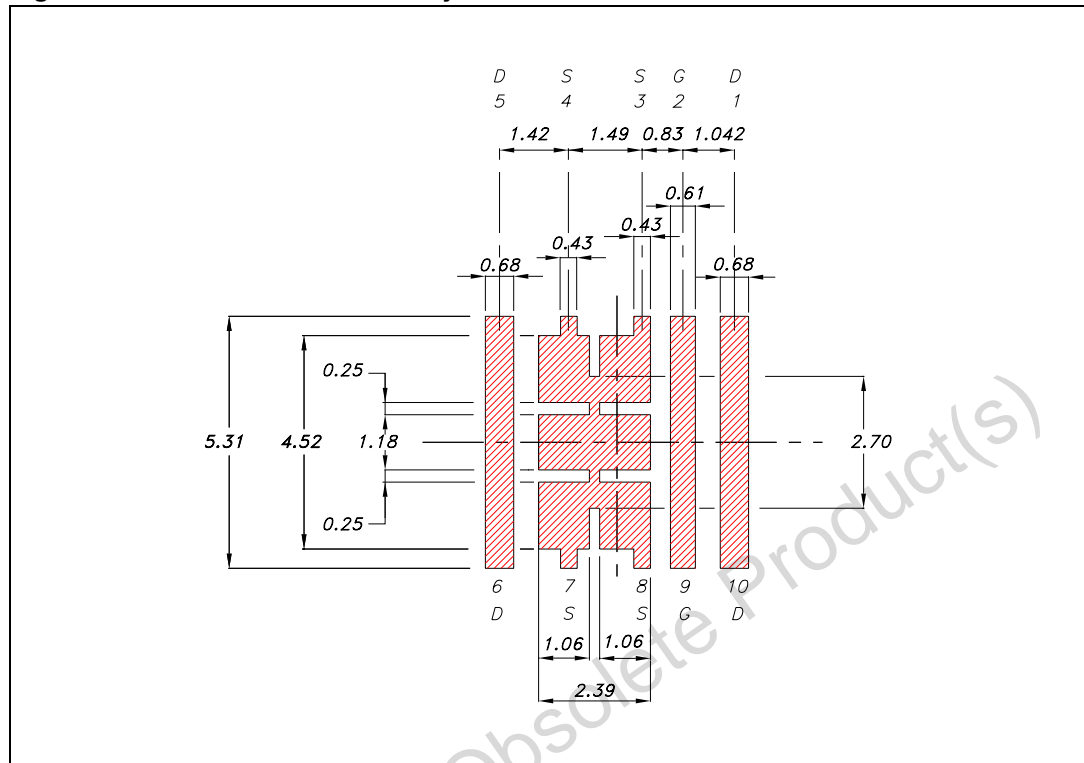
| Ref. | mm | | | inch | | |
|------|------|------|------|-------|-------|-------|
| | Min. | Typ. | Max. | Min. | Typ. | Max. |
| A | 0.75 | 0.80 | 0.85 | 0.030 | 0.031 | 0.033 |
| A1 | | | 0.05 | | | 0.002 |
| b1 | 0.48 | 0.58 | 0.68 | 0.019 | 0.023 | 0.027 |
| b2 | 0.41 | 0.51 | 0.61 | 0.016 | 0.020 | 0.024 |
| b3 | 2.19 | 2.29 | 2.39 | 0.086 | 0.090 | 0.094 |
| b4 | 0.89 | 1.04 | 1.19 | 0.035 | 0.041 | 0.047 |
| b5 | 0.23 | 0.33 | 0.43 | 0.009 | 0.013 | 0.017 |
| c | 0.20 | 0.25 | 0.30 | 0.008 | 0.010 | 0.012 |
| D | 6 | 6.15 | 6.30 | 0.236 | 0.242 | 0.248 |
| D1 | 5.74 | 5.89 | 6.04 | 0.226 | 0.232 | 0.238 |
| E | 5.01 | 5.16 | 5.31 | 0.197 | 0.203 | 0.209 |
| E1 | 4.75 | 4.90 | 5.05 | 0.187 | 0.193 | 0.199 |
| H1 | 0.23 | | | 0.009 | | |
| H2 | 0.45 | | 0.56 | 0.018 | | 0.022 |
| H3 | 0.31 | 0.41 | 0.51 | 0.012 | 0.016 | 0.020 |
| H4 | 0.45 | | 0.56 | 0.018 | | 0.022 |
| K1 | 4.22 | 4.37 | 4.52 | 0.166 | 0.172 | 0.178 |
| K2 | 1.08 | 1.13 | 1.18 | 0.043 | 0.044 | 0.046 |
| K3 | 1.37 | | | 0.054 | | |
| K4 | 0.24 | | | 0.009 | | |
| M1 | 4.30 | 4.50 | 4.70 | 0.169 | 0.177 | 0.185 |
| M2 | 3.43 | 3.58 | 3.73 | 0.135 | 0.141 | 0.147 |
| M3 | 0.22 | | | 0.009 | | |
| M4 | 0.05 | | | 0.002 | | |
| P1 | 0.15 | 0.20 | 0.25 | 0.006 | 0.008 | 0.010 |
| T1 | 3.48 | 3.64 | 4.10 | 0.137 | 0.143 | 0.161 |
| T2 | 0.56 | 0.76 | 0.95 | 0.022 | 0.030 | 0.037 |
| T3 | 1.20 | | | 0.047 | | |
| T4 | 3.90 | | | 0.154 | | |
| T5 | | 0.18 | 0.36 | | 0.007 | 0.014 |
| < | 0° | 10° | 12° | 0° | 10° | 12° |

Figure 22. PolarPAK® (option “L”) drawings



Obsolete Product(s) - Obsolete Product(s)

Figure 23. Recommended PAD layout



5 Revision history

Table 9. Document revision history

| Date | Revision | Changes |
|-------------|----------|---|
| 10-Nov-2005 | 1 | First version |
| 19-Dec-2005 | 2 | Complete version |
| 30-Jan-2006 | 3 | Modified description on first page |
| 21-Mar-2006 | 4 | The document has been reformatted |
| 25-May-2006 | 5 | New note on Table 2 |
| 10-Oct-2006 | 6 | Modified general features |
| 08-May-2007 | 7 | New data on Table 5 and new Figure 21 |
| 03-Sep-2007 | 8 | Updated mechanical data |
| 01-Oct-2007 | 9 | Inserted new Figure 23: Recommended PAD layout |

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